

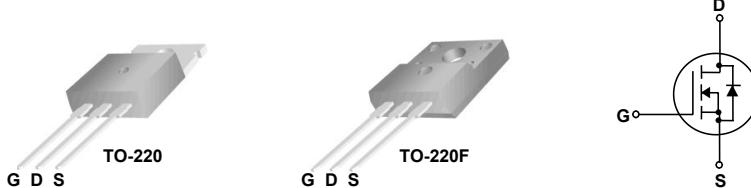
## **SLP65R190SJ / SLF65R190SJ 650V N-Channel MOSFET**

### **General Description**

This Power MOSFET is produced using Maple semi's Advanced Super-Junction technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for AC/DC power conversion in switching mode operation for higher efficiency.

### **Features**

- 20A, 650V,  $R_{DS(on)}$  typ. =  $0.16\Omega$ @ $V_{GS} = 10\text{ V}$
- Low gate charge ( typical 70nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### **Absolute Maximum Ratings**

$T_c = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	SLP65R190SJ	SLF65R190SJ	Units
$V_{DSS}$	Drain-Source Voltage	650		V
$I_D$	Drain Current - Continuous ( $T_c = 25^\circ\text{C}$ )	20	20 *	A
	- Continuous ( $T_c = 100^\circ\text{C}$ )	10	10 *	A
$I_{DM}$	Drain Current - Pulsed	(Note 1)	62	A
$V_{GSS}$	Gate-Source Voltage		$\pm 30$	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	485	mJ
$I_{AR}$	Avalanche Current	(Note 1)	20	A
$E_{AR}$	Repetitive Avalanche Energy	(Note 1)	1	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
$P_D$	Power Dissipation ( $T_c = 25^\circ\text{C}$ )	205	35	W
	- Derate above $25^\circ\text{C}$	1.67	0.3	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range		-55 to +150	$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

### **Thermal Characteristics**

Symbol	Parameter	SLP65R190SJ	SLF65R190SJ	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.6	3.6	$^\circ\text{C}/\text{W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	80	$^\circ\text{C}/\text{W}$

**Electrical Characteristics** $T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	650	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.6	--	$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 650 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{\text{DS}} = 480 \text{ V}, T_C = 125^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA
<b>On Characteristics</b>						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	2.5	--	4.5	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 5 \text{ A}$	--	0.16	0.19	$\Omega$
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}} = 40 \text{ V}, I_D = 5 \text{ A}$ (Note 4)	--	16	--	S
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	1440	--	pF
$C_{\text{oss}}$	Output Capacitance		--	300	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	10	--	pF
<b>Switching Characteristics</b>						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 400 \text{ V}, I_D = 5 \text{ A}, R_G = 20 \Omega$ (Note 4, 5)	--	25	--	ns
$t_r$	Turn-On Rise Time		--	55	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	70	--	ns
$t_f$	Turn-Off Fall Time		--	40	--	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 480 \text{ V}, I_D = 10 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	70	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	7.8	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	9	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_s$	Maximum Continuous Drain-Source Diode Forward Current	--	--	20	--	A
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	60	--	A
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_s = 4.9 \text{ A}$	--	--	1.5	V
$t_{\text{rr}}$	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_s = 4.9 \text{ A}, dI_F / dt = 100 \text{ A/us}$	--	475	--	ns
$Q_{\text{rr}}$	Reverse Recovery Charge	(Note 4)	--	5.8	--	uC

**Notes:**

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2.  $I_{\text{AS}} = 3.5 \text{ A}$ ,  $V_{\text{DD}} = 50 \text{ V}$ ,  $R_G = 25 \Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{\text{SD}} \bullet I_D$ ,  $dI/dt \bullet 200 \text{ A/us}$ ,  $V_{\text{DD}} \bullet \text{BV}_{\text{DSS}}$ , Starting  $T_J = 25^\circ\text{C}$
4. Pulse Test : Pulse width  $\bullet 300 \text{ us}$ , Duty cycle  $\bullet 2\%$
5. Essentially independent of operating temperature

### Typical Characteristics

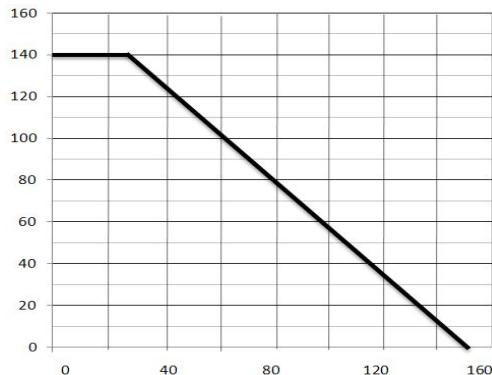


Figure 1. Power Dissipation for SLP65R190SJ

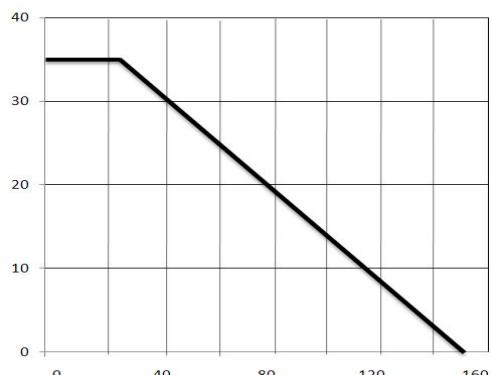


Figure 2. Power Dissipation for SLF65R190SJ

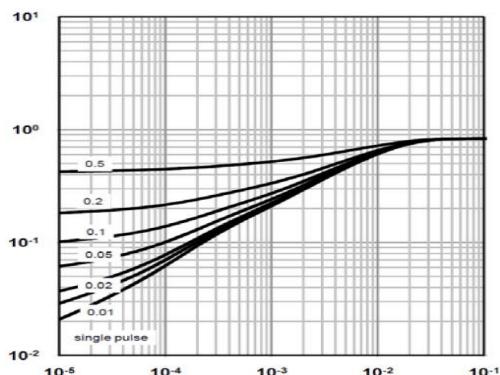


Figure 3. Transient Thermal Response Curve for SLP65R190SJ

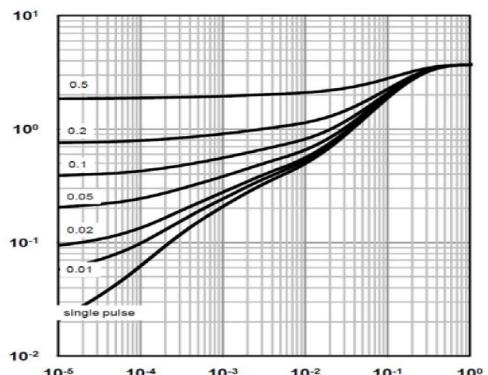


Figure 4. Transient Thermal Response Curve for SLF65R190SJ

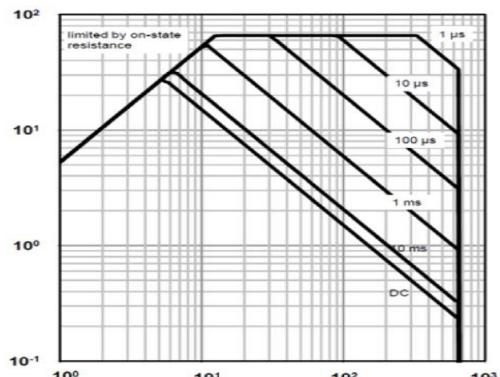


Figure 5. Maximum Safe Operating Area for SLP65R190SJ@25°C

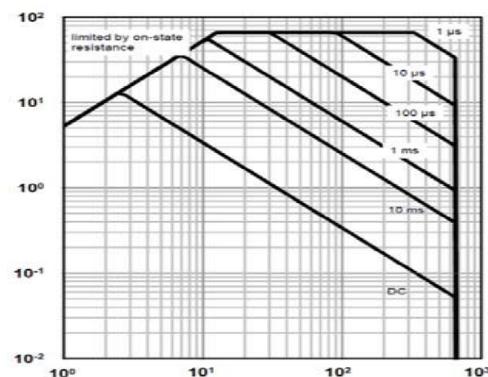


Figure 6. Maximum Safe Operating Area for SLF65R190SJ@25°C

**Typical Characteristics** (Continued)

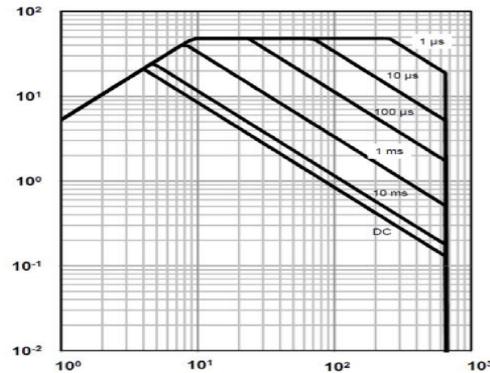


Figure 7. Maximum Safe Operating Area for SLP65R190SJ@80°C

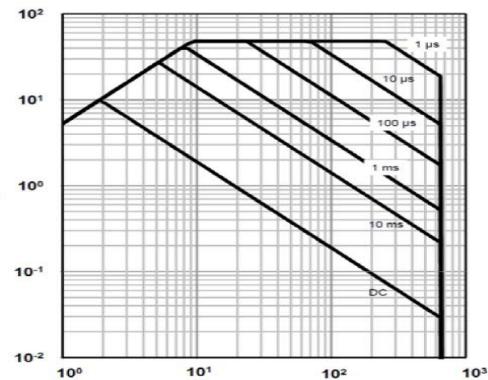


Figure 8. Maximum Safe Operating Area for SLP65R190SJ@80°C

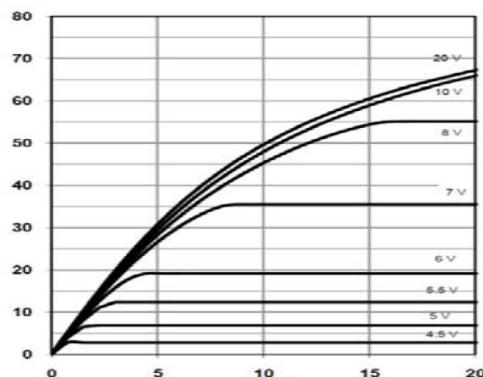


Figure 9. On-Region Characteristics@25°C

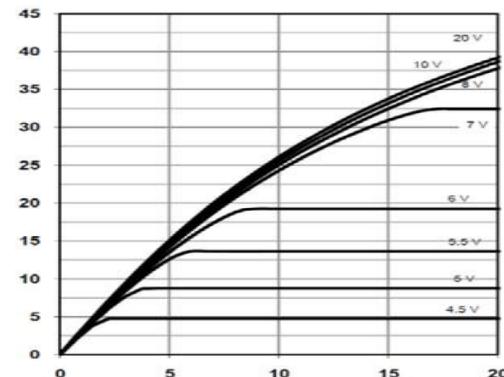


Figure 10. On-Region Characteristics@125°C

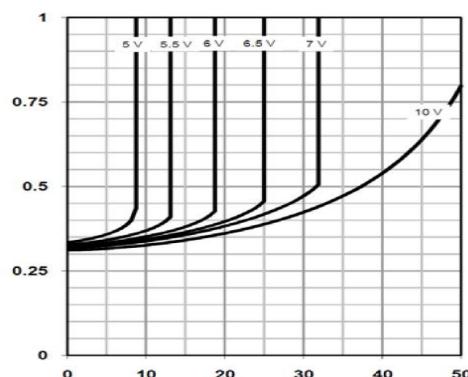


Figure 11. On-Resistance Variation vs Drain Current and Gate Voltage@125°C

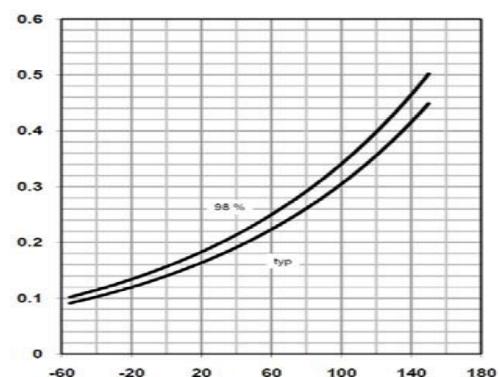


Figure 12. On-Resistance Variation vs Temperature

**Typical Characteristics** (Continued)

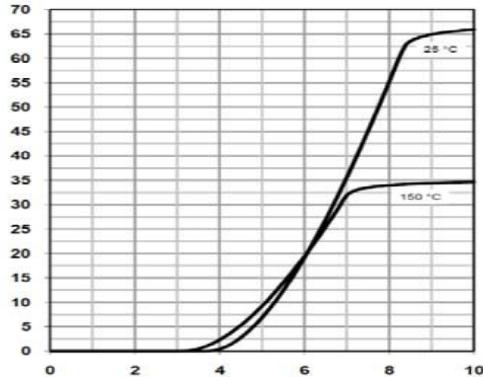


Figure 13. Transfer Characteristics

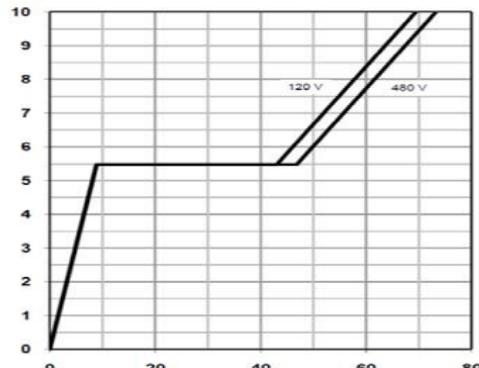


Figure 14. Gate Charge Characteristics

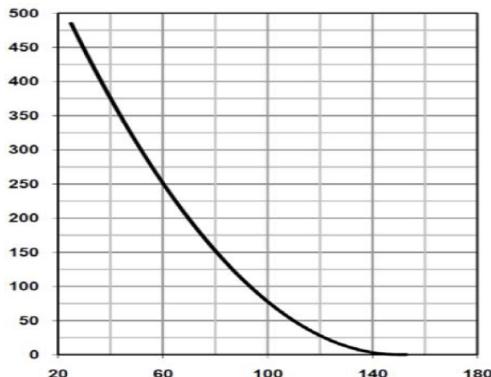


Figure 15. Avalanche Energy Characteristics

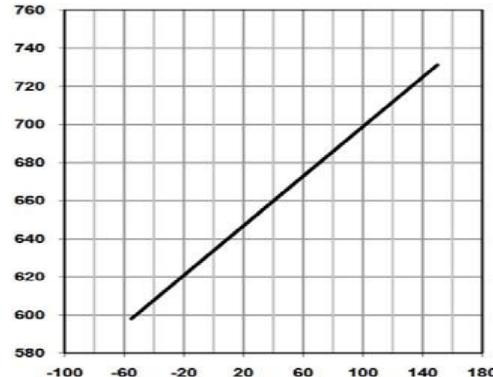


Figure 16. Breakdown Voltage Variation vs Temperature

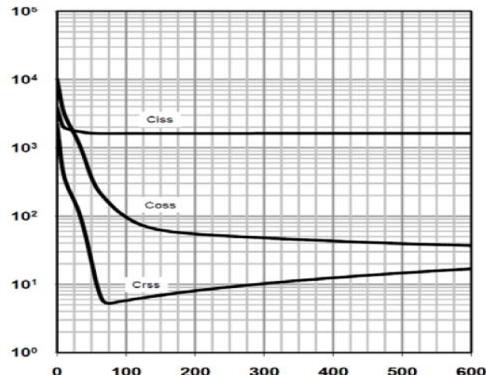


Figure 17. Capacitance Characteristics

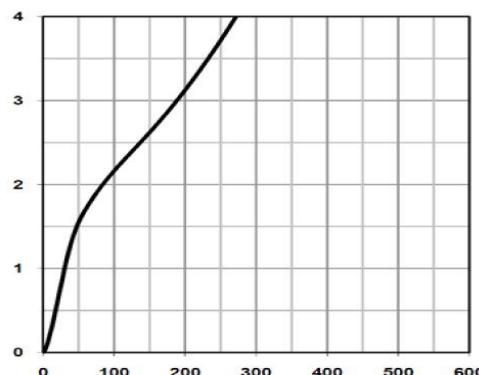
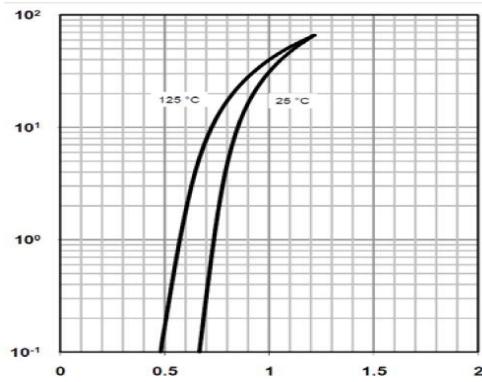


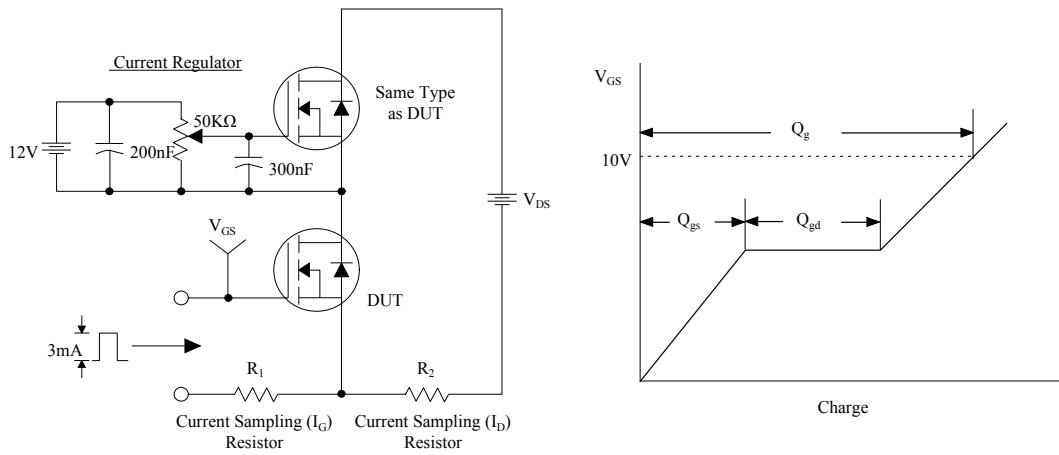
Figure 18. On-Resistance Variation vs Temperature

**Typical Characteristics** (Continued)

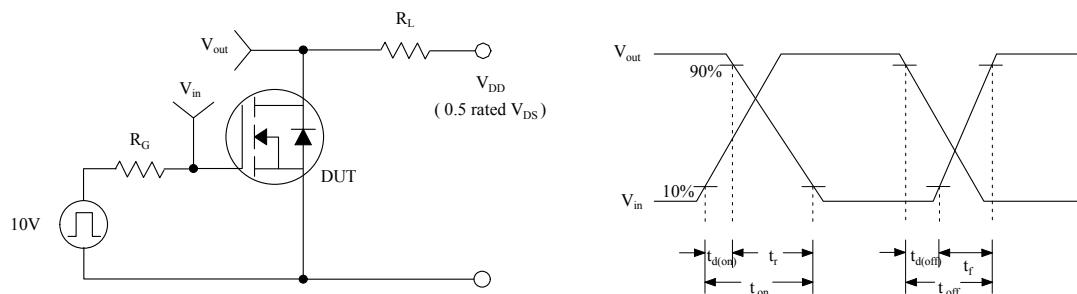


**Figure 19. Body Diode Forward Voltage Variation with Source Current and Temperature**

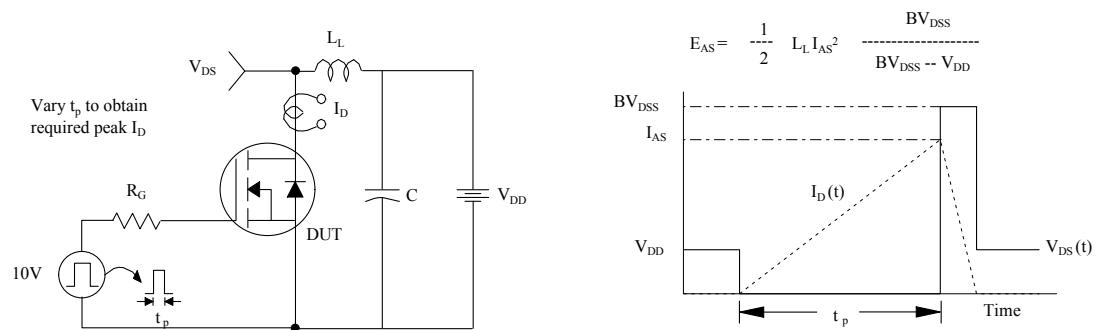
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms



### Peak Diode Recovery dv/dt Test Circuit & Waveforms

